

Notice of References CitedApplication/Control No.
09/608,008Applicant(s)/Patent Under
Reexamination
NAKAYAMA, TOSHIHIROExaminer
Ryan R YangArt Unit
2672

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,819,103 ✓	10-1998	Endoh et al.	710/1
	B	US-4,202,041 ✓	05-1980	Kaplow et al.	341/26
	C	US-5,659,639 ✓	08-1997	Mahoney et al.	382/309
	D	US-5,381,525 ✓	01-1995	Iguchi, Katsumi	345/649
	E	US-5,490,246 ✓	02-1996	Brotsky et al.	345/763
	F	US-5,237,648 ✓	08-1993	Mills et al.	345/723
	G	US-5,675,753 ✓	10-1997	Hansen et al.	345/744
	H	US-6,469,715 ✓	10-2002	Carter et al.	345/763
	I	US-6,426,759 ✓	07-2002	Ting et al.	345/763
	J	US-6,037,940 ✓	03-2000	Schroeder et al.	345/763
	K	US-5,831,611 ✓	11-1998	Kennedy et al.	345/763
	L	US-5,745,113 ✓	04-1998	Jordan et al.	345/835
	M	US-6,157,747 ✓	12-2000	Szeliski et al.	382/284

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/608,008	Applicant(s)/Patent Under Reexamination NAKAYAMA, TOSHIHIRO	
	Examiner Ryan R Yang	Art Unit 2672	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,144,375 ✓	11-2000	Jain et al.	707/500.1
	B	US-5,745,126 ✓	04-1998	Jain et al.	382/154
	C	US-5,491,795 ✓	02-1996	Beaudet et al.	345/804
	D	US-5,404,316 ✓	04-1995	Klingler et al.	345/723
	E	US-6,204,840 ✓	03-2001	Petelycky et al.	707/500.1
	F	US-5,682,326 ✓	10-1997	Klingler et al.	707/500.1
	G	US-5,675,752 ✓	10-1997	Scott et al.	345/866
	H	US-6,081,264	06-2000	Rosen et al.	345/723
	I	US-6,091,427 ✓	07-2000	Boezeman et al.	345/474
	J	US-6,154,601 ✓	11-2000	Yaegashi et al.	386/52
	K	US-6,327,420 ✓	12-2001	Furukawa, Takashi	386/52
	L	US-6,236,395 ✓	05-2001	Sezan et al.	345/723
	M	US-6,463,444 ✓	10-2002	Jain et al.	707/104.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/608,008	Applicant(s)/Patent Under Reexamination NAKAYAMA, TOSHIHIRO	
	Examiner Ryan R Yang	Art Unit 2672	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,850,352	12-1998	Moezzi et al.	345/419
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.